

Notice of References Cited	Application/Control No. 10/579,294		Applicant(s)/Patent Under Reexamination SUDO ET AL.	
	Examiner QUANG NGUYEN, Ph.D.		Art Unit 1633	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0073391	04-2004	Mitaka et al.	702/081
*	B	US-2004/0028657	02-2004	Okano et al.	424/93.7
*	C	US-7521231	04-2009	Germain et al.	435/325
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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